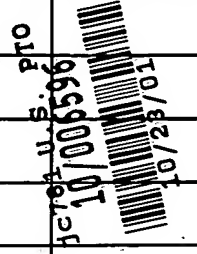


<p style="text-align: center;">INFORMATION DISCLOSURE CITATION (Use several sheets if necessary)</p>	ATTY DOCKET NO. POU9200001	SERIAL NO.
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U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
AA	4,819,233	04/04/89	Delucia et al.	371	19	
AB	4,864,569	09/05/89	Delucia et al.	371	19	
AC	5,107,497	04/21/92	Lirov et al.	371	15.1	
AD	5,265,254	11/23/93	Blasciak et al.	395	700	
AE	5,335,342	08/02/94	Pope et al.	395	575	
AF	5,363,501	11/08/94	Pullela	395	500	
AG	5,371,883	12/06/94	Gross et al.	395	575	
AH	5,450,586	09/12/95	Kuzara et al.	395	700	
AI	5,481,717	01/02/96	Gaboury	395	700	
AJ	5,581,696	12/03/96	Kolawa et al.	395	183.14	
AK	5,594,892	01/14/97	Bonne et al.	395	500	

FOREIGN PATENT DOCUMENTS

DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
					YES	NO
AEE	JP 09138612	Japan	G06F	17/50		

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

	AFF	Generalized Algorithmic Debugging and Testing, Peter Fritzson, Nahid Shahmehri and Mariam Kamkar, ACM Letters on Programming Languages and Systems, Vol. 1, No. 4, December 1992, pp. 303-322.
	AGG	Object-Oriented Program Tracing and Visualization, Danny B. Lange and Yuichi Nakamura, Computer, May 1997, pp. 63-70.

EXAMINER	DATE CONSIDERED
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U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AW	5,867,710	02/02/99	Dorris et al.	395	704	
	AX	5,892,947	04/06/99	DeLong et al.	395	701	
	AY	5,896,535	04/20/99	Ronstrom	395	701	
	AZ	5,905,856	05/18/99	Ottenssooser	395	183.14	
	AAA	5,933,640	08/03/99	Dion	395	704	
	ABB	5,963,739	10/05/99	Homeier	395	704	
	ACC	6,002,869	12/04/99	Hinckley	395	704	
	ADD	6,031,990	02/29/00	Sivakumar et al.	395	704	

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		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO

OTHER DOCUMENTS <i>(Including Author, Title, Date, Pertinent Pages, Etc.)</i>			

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				APPLICANT(S) Apuzzo et al.				<div style="display: flex; align-items: center;"> <div style="writing-mode: vertical-rl; transform: rotate(180deg); font-size: small; margin-right: 5px;"> 10/006596 10/23/01 </div> </div>	
				FILING DATE Herewith		GROUP			

U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AL	5,602,990	02/11/97	Leete	395	183.22	
	AM	5,651,111	07/22/97	McKeeman et al.	395	183.14	
	AN	5,715,387	02/03/98	Barnstijn et al.	395	183.14	
	AO	5,732,213	03/24/98	Gessel et al.	395	200.11	
	AP	5,740,442	04/14/98	Cox et al.	395	704	
	AQ	5,751,941	05/12/98	Hinds et al.	395	183.14	
	AR	5,758,061	05/26/98	Plum	395	183.11	
	AS	5,761,408	06/02/98	Kolawa et al.	395	183.14	
	AT	5,774,725	06/30/98	Yadav et al.	395	704	
	AU	5,784,553	07/21/98	Kolawa et al.	395	183.14	
	AV	5,860,011	01/12/99	Kolawa et al.	395	708	

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		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO

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		AHH	Dominators, Super Blocks and Program Coverage, Hiralal Agrawal, pp. 25-34.
		AII	An Observability-Based Code Coverage Metric for Function Simulation, Srinivas Devadas, Abhijit Ghosh, Kurt Keutzer, ICCAD '96

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